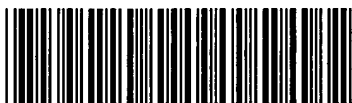


**Search Notes**

Application/Control No.

10/549,906

Examiner

Mark L. Berch

Applicant(s)/Patent under  
Reexamination

IMAI ET AL.

Art Unit

1624

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
540/222 as PGPub		4/5/2007	MLB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
540/222 or text term to date	4/5/2007	MLB